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METHOD FOR CORRECTING MEASUREMENT  
ERROR, METHOD OF DETERMINING QUALITY  
OF ELECTRONIC COMPONENT, AND DEVICE FOR  
MEASURING CHARACTERISTIC OF ELECTRONIC COMPONENT

ABSTRACT OF THE DISCLOSURE

The impedance of a correction-data obtaining sample is measured by a standard measuring device and an actual measuring device so as to obtain an interrelated expression of the measurement results generated by the standard and actual measuring devices. The impedance of an electronic component measured by the actual measuring device is substituted into the interrelated expression and the expression is calculated. Accordingly, the impedance of the electronic component is corrected to the impedance which would be obtained from the standard measuring device.